

AON6298

100V N-Channel MOSFET

General Description

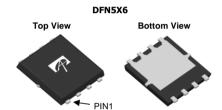
The AON6298 uses trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of R_{DS(ON)}, Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

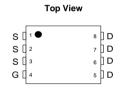
Product Summary

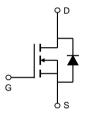
 $\begin{array}{lll} V_{DS} & 100V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 46A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 16.5 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 6V) & < 21 m\Omega \\ \end{array}$

100% UIS Tested 100% R_g Tested









Absolute Maximum Ratings T _A =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		V _{DS}	100	V			
Gate-Source Voltage		V _{GS}	±20	V			
Continuous Drain Current	T _C =25°C		46				
	T _C =100°C	I _D	30	A			
Pulsed Drain Current C		I _{DM}	95				
Continuous Drain Current	T _A =25°C		14.5	Δ			
	T _A =70°C	IDSM	11.5	Α Α			
Avalanche Current C		I _{AS}	15	A			
Avalanche energy L=0.1mH ^C		E _{AS}	11	mJ			
Power Dissipation ^B	T _C =25°C	В	78	W			
	T _C =100°C	P _D	31	VV			
	T _A =25°C	Р	7.4	W			
Power Dissipation ^A	T _A =70°C	P _{DSM}	4.7	VV			
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C			

Thermal Characteristics							
Parameter	Symbol Typ		Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	D	14	17	°C/W		
Maximum Junction-to-Ambient AD	Steady-State $R_{\theta JA}$		40	55	°C/W		
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.25	1.6	°C/W		



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		100			V		
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =100V, V_{GS} =0V				1	μА		
	Zero Gate Voltage Drain Gurrent		T _J =55°C			5	μΑ		
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		2.4	2.85	3.4	V		
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V		95			Α		
		V_{GS} =10V, I_D =20A			13.7	16.5	mΩ		
R _{DS(ON)}	Static Drain-Source On-Resistance		T _J =125°C		25.7	31	1112.2		
		V_{GS} =6V, I_D =20A			16.6	21	mΩ		
g FS	Forward Transconductance	V_{DS} =5V, I_D =20A			43		S		
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V			0.73	1	V		
I _S	Maximum Body-Diode Continuous Current					46	Α		
DYNAMIC	CPARAMETERS								
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, f=1MHz			1307		pF		
C _{oss}	Output Capacitance				127		pF		
C _{rss}	Reverse Transfer Capacitance				8		pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz		0.6	1.25	1.9	Ω		
SWITCHI	NG PARAMETERS				-				
$Q_{g(10V)}$	Total Gate Charge				16	23	nC		
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =50V, I _D =20A			5		nC		
Q_{gd}	Gate Drain Charge				3		nC		
t _{D(on)}	Turn-On DelayTime				7.5		ns		
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =50V, R_L =2.5 Ω , R_{GEN} =3 Ω			2.5		ns		
$t_{D(off)}$	Turn-Off DelayTime				16.5		ns		
t _f	Turn-Off Fall Time				3		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs			30		ns		
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=500A/μs			132		nC		

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ t \leq 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

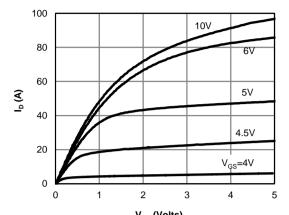
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

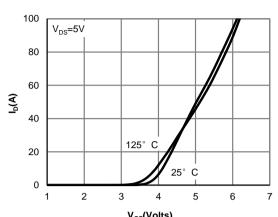
H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C.



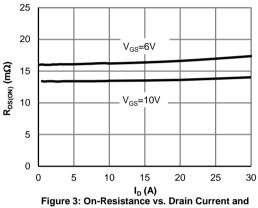
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



Gate Voltage (Note E)

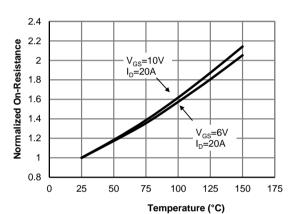
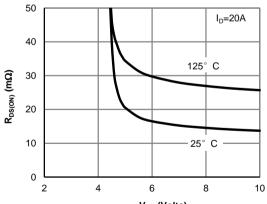
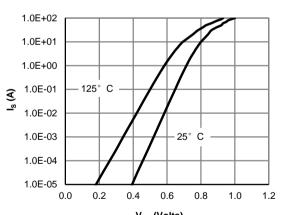


Figure 4: On-Resistance vs. Junction Temperature (Note E)



V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

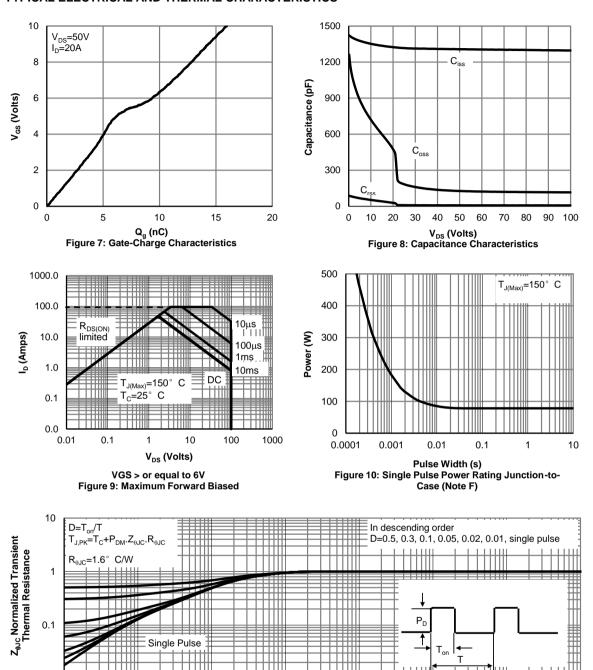


0.01 L 1E-05

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

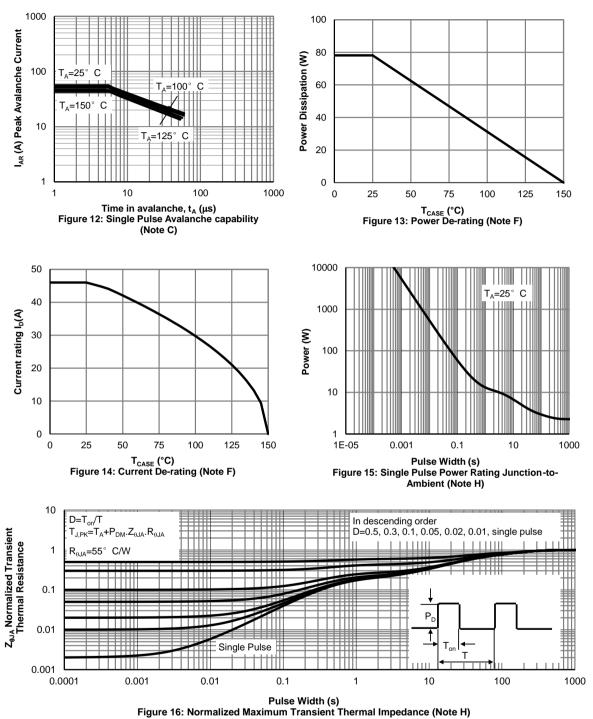
10

100

0.01

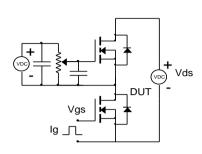


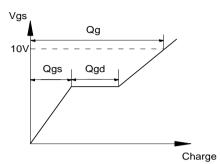
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



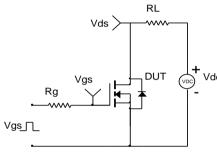


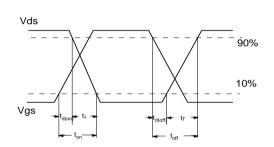
Gate Charge Test Circuit & Waveform



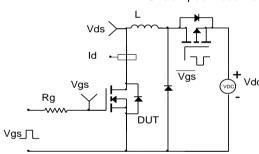


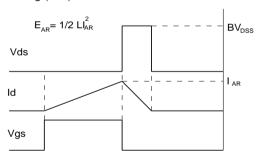
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

